

Advanced CV-Measurements and Calibration at the Wafer-Level

Quick How-To Reference

C-V Instrumentations

Agilent 4980A

Agilent 4294A

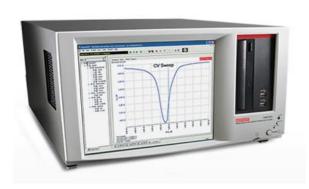
Keysight E4990A







Keithley 4200-SCS



Keysight B1500A



C-V Instrumentations: Auto-Balancing Bridge Method

- Keithley 4200+CVU: 1 kHz to 10 MHz | DC Bias: Up to 30V
- Agilent B1500+MFCMU: 1 kHz to 5Mz | DC Bias: Up to 25V
- Agilent 4980A : 20 Hz to 2 MHz | DC Bias : Up to 40V
- Agilent 4294A: 40 Hz to 110MHz |DC Bias: Up to 40V
- Agilent 4981A: 120 Hz to 1 MHz | DC Bias: None
- Keysight E4990A: 20Hz to 120MHz | DC Bias: Up to 40V NEW

Auto-Balancing Bridge Method (ABB)

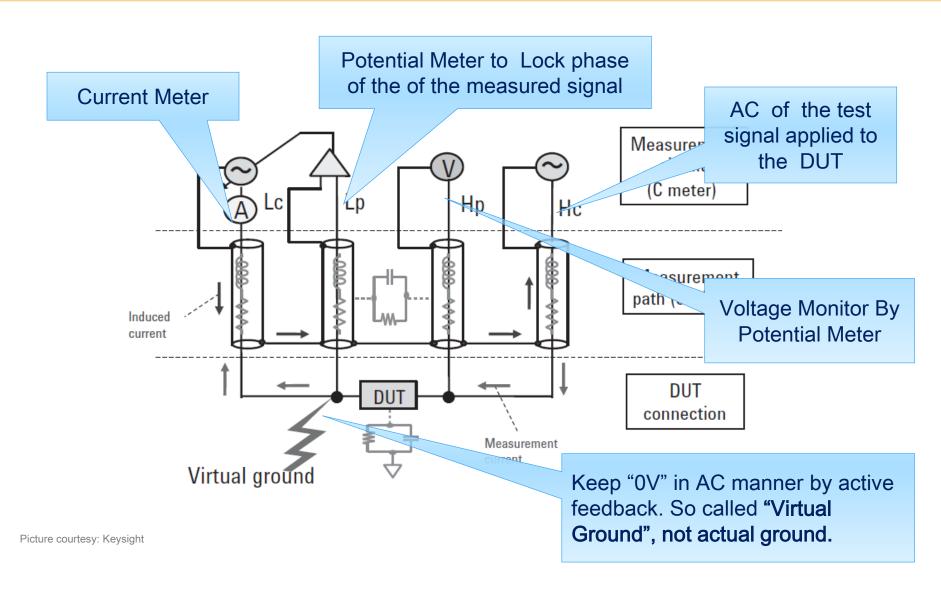
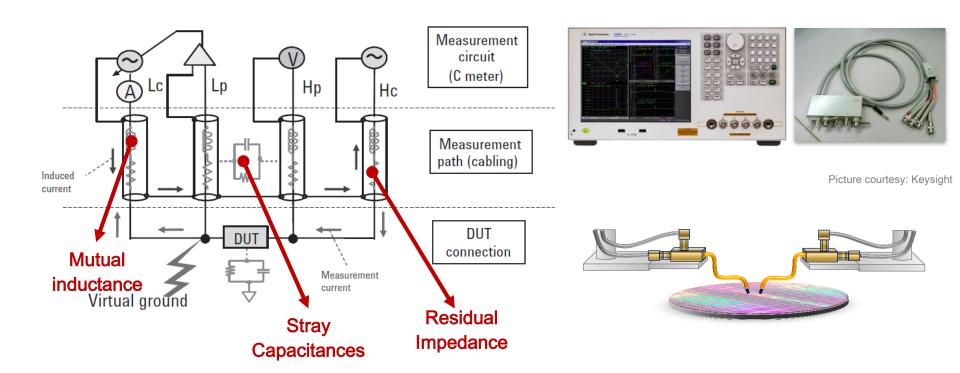
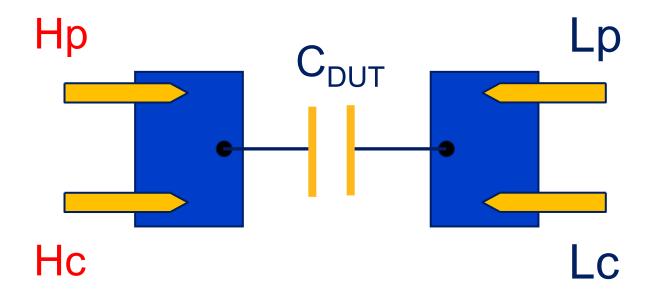


ABB: Sources of Errors



- Residual impedance in the cables
- Stray capacitance between cables or to ground
- Mutual inductance caused by the current flow between adjacent cables

ABB: Sources of Errors



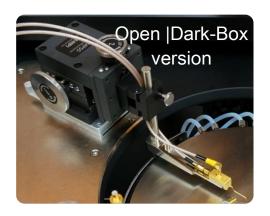
Eliminate cable resistance from the measurements

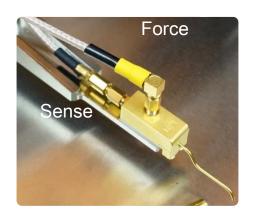
MPI Solutions: Kelvin Probe Arm

- Eliminate the effects of the residual impedance
- Shielding the cables to eliminate stray capacitance
- Vertical self-leveling for easy tip replacement
- 2M | 1M Direct Impedance Analyzer BNC to SSMB to Probe with no disturbance
- Easy to reconnect for different IV/CV/PIV measurements
- For Ultra Low noise and accurate IV/CV Measurement in open and Shield Environment System



ShieldEnclosure Version



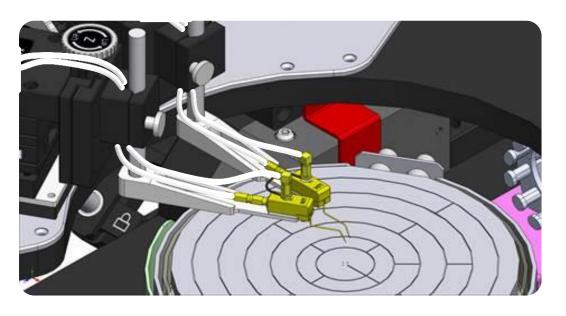


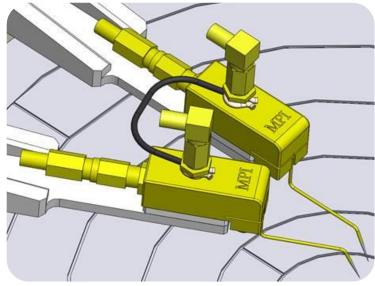


MPI Solutions: V-Ground Connector

- Provide 4-TP Connection for accurate CV at higher frequency >2MHz
- Eliminate the mutual inductance between cables
- Provides the shortest connection for virtual ground
- Included in the Kelvin Probe

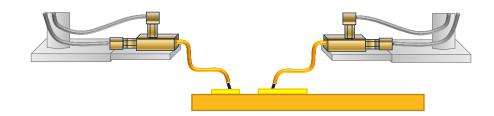






On wafer verification on Calibration Substrate

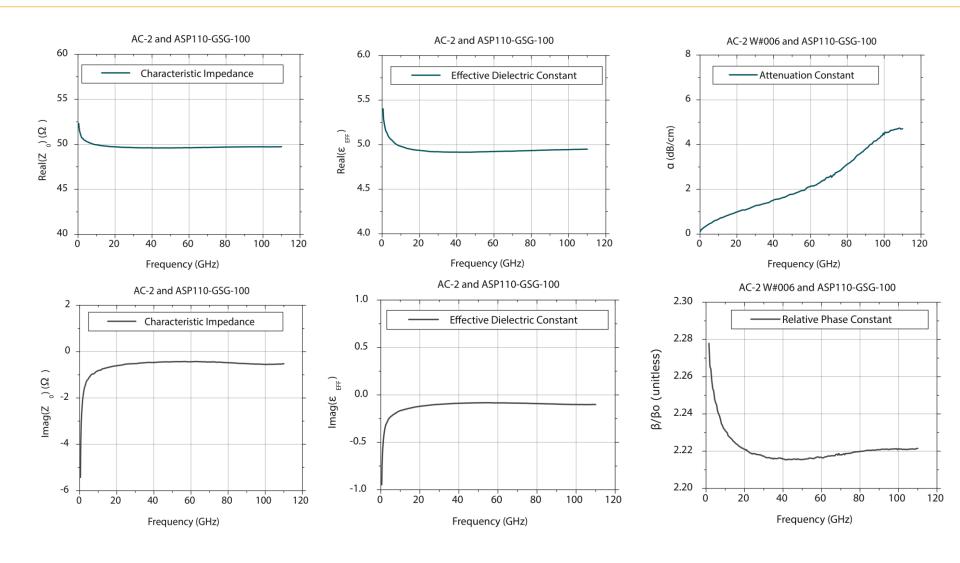
- System needs to be calibrated with Open/Short or Open/Short/Load calibration method from the CV instruments prior to any measurement
- MPI calibration substrates include required standards and are qualified using the NIST methodology
 - loads are accurately trimmed to 50 Ohm with < 0.3% error
 - reference capacitance for CV calibration verification
- Recommended substrate models:
 - AC-3 for DUT pads < 50 um x 50 um
 - AC-5 for lager pads



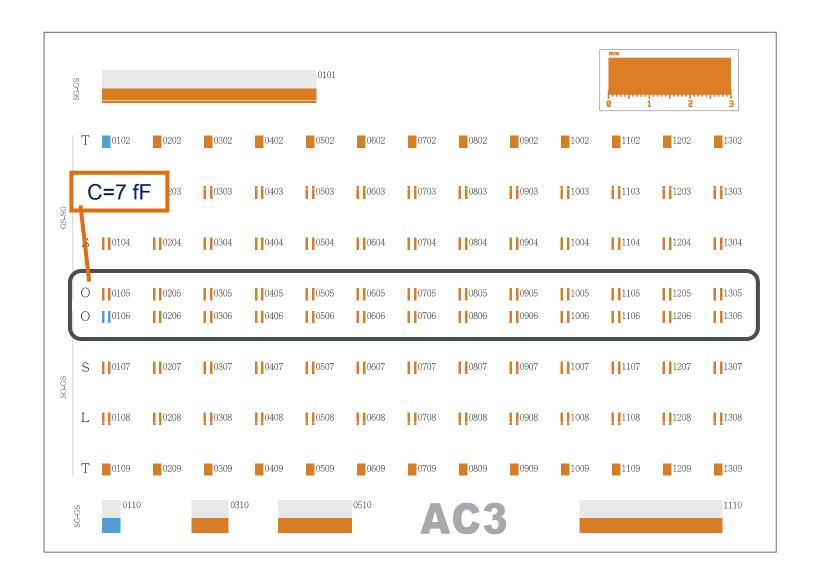
Calibration Substrates Qualified: AC-2 Example

Nominal capacitance per unit length, pF/cm	1.492
Nominal characteristic impedance @20 GHz	50 Ω
Effective dielectric constant @20 GHz, real part	4.94
Effective velocity factor @20 GHz	0.45
Parameters of the simplified model of line losses	
Reference loss, dB	0.34
Reference delay, ps	25.5
Reference frequency, GHz	20
AC-2	

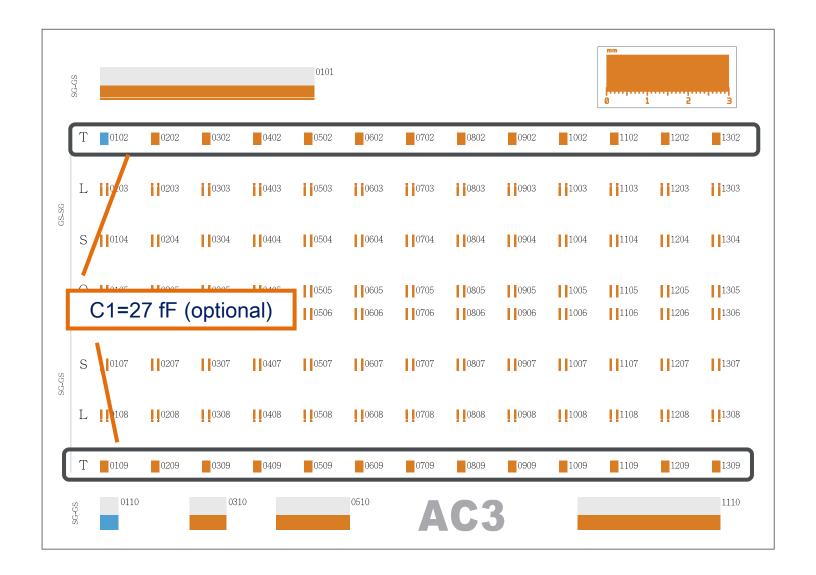
Calibration Substrates Qualified: NIST methodology



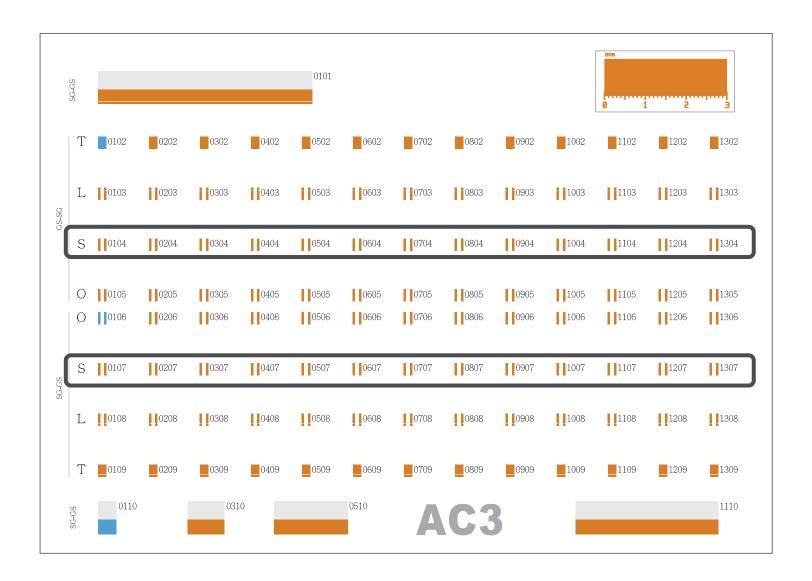
AC-3: Open Standards



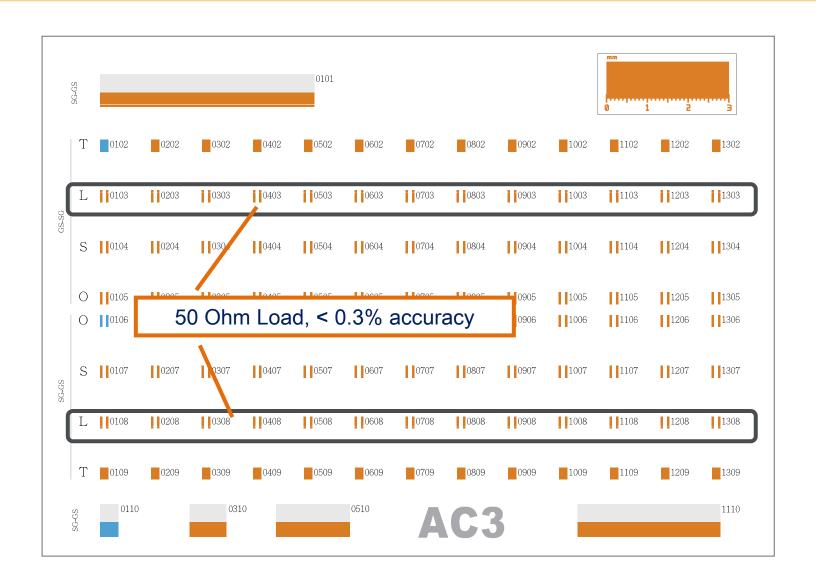
AC-3: Open Standards (Optional)



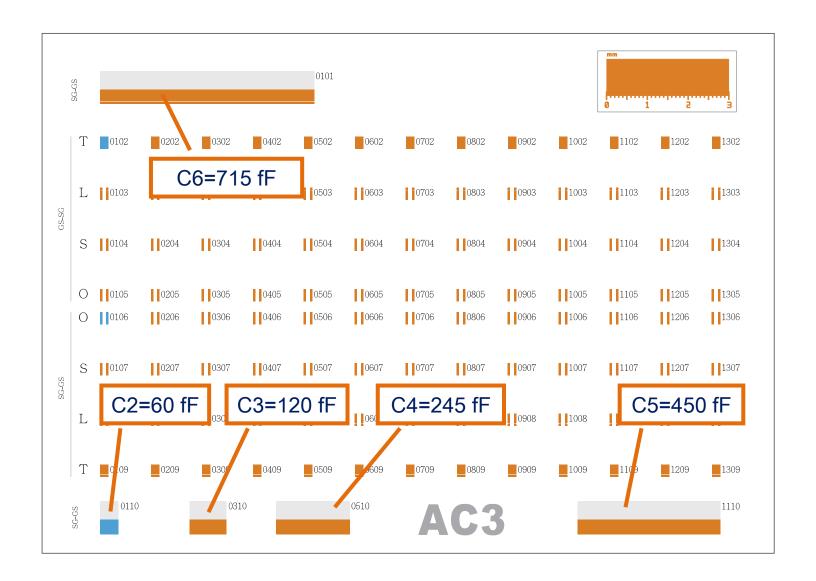
AC-3: Short Standards



AC-3: Calibration Loads



AC-3: Verification Capacitances



Thank you

MPICORPORATION